

# **100V N-Channel MOSFETs**

Pb RoHS

#### **General Description**

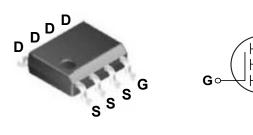
These N-Channel enhancement mode power field effect transistors are using trench DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency fast switching applications.

BV <sub>DSS</sub>	R <sub>DS(ON)</sub>	Ι <sub>D</sub>
100 V	85 mΩ	4 A

#### Features

- $R_{DS(ON)} \leq 85 m \Omega @V_{GS} = 10V$
- Improved dv/dt Capability
- Fast Switching
- Green Device Available

#### SOP-8 Pin Configuration



#### Applications

- Power Management Switches
- DC/DC Converters

Absolute Maximum Ratings T <sub>c</sub> =25°C unless otherwise noted						
Symbol	Parameter	Value	Units			
V <sub>DS</sub>	Drain-Source Voltage	100	V			
V <sub>GS</sub>	Gate-Source Voltage	±20	V			
I-	Drain Current - Continuous (T <sub>C</sub> =25°C)	4	Α			
I <sub>D</sub>	Drain Current - Continuous (T <sub>C</sub> =100°C)	2.5	Α			
I <sub>DM</sub>	Drain Current - Pulsed (NOTE 1)	16	Α			
P <sub>D</sub>	Power Dissipation (T <sub>C</sub> =25°C)	3.1	W			
EAS	Single Pulse Avalanche Energy (NOTE 2)	3.2	mJ			
TJ	Operating Junction Temperature Range	-55 to 150	°C			
T <sub>STG</sub>	Storage Temperature Range	-55 to 150	°C			
Marking Code		NM085				

Thermal Characteristics				
Symbol	Parameter	Value	Unit	
$R_{ extsf{ heta}JA}$	Thermal Resistance Junction to Ambient	40.3	°C/W	





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#### Electrical Characteristics (T<sub>J</sub>=25°C, unless otherwise noted)

Off Characteristics						
Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V , I <sub>D</sub> =250uA	100			V
I <sub>DSS</sub>	Drain-Source Leakage Current	V <sub>DS</sub> =100V , V <sub>GS</sub> =0V			10	uA
I <sub>GSS</sub>	Gate-Source Leakage Current	$V_{GS}$ =±20V , $V_{DS}$ =0V			±100	nA

#### **On Characteristics**

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
R <sub>DS(ON)</sub>	IStatic Drain-Source On-Resistance	V <sub>GS</sub> =10V , I <sub>D</sub> =4A			85	mΩ
		V <sub>GS</sub> =4.5V , I <sub>D</sub> =2A			110	
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{GS}=V_{DS}$ , I <sub>D</sub> =250uA	1.0	2.0	3.0	V
gfs	Forward Transconductance	V <sub>DS</sub> =5V , I <sub>D</sub> =5A		15		S

#### **Dynamic and switching Characteristics**

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Qg	Total Gate Charge			12		
$Q_gs$	Gate-Source Charge	$V_{DS}$ =50V , $V_{GS}$ =10V , $I_{D}$ =5A		2.9		nC
$Q_gd$	Gate-Drain Charge			1.8		
$T_{d(on)}$	Turn-On Delay Time			3.9		
Tr	Rise Time	$V_{DD}$ =50V , $V_{GS}$ =10V , $R_{G}$ =3 $\Omega$ ,		26		nS
$T_{d(off)}$	Turn-Off Delay Time	I <sub>D</sub> =5A		16.2		113
T <sub>f</sub>	Fall Time			8.9		
C <sub>iss</sub>	Input Capacitance			1233		
C <sub>oss</sub>	Output Capacitance	V <sub>DS</sub> =50V , V <sub>GS</sub> =0V , F=1MHz		32		pF
C <sub>rss</sub>	Reverse Transfer Capacitance			26		
Rg	Gate resistance	V <sub>GS</sub> =0V , V <sub>DS</sub> =0V , F=1MHz		1.4		Ω

#### **Drain-Source Diode Characteristics and Ratings**

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
I <sub>S</sub>	Continuous Source Current	$V_G = V_D = 0V$ , Force Current			4	А
$V_{SD}$	Diode Forward Voltage	V <sub>GS</sub> =0V , I <sub>S</sub> =1A			1.2	V
t <sub>rr</sub>	Reverse Recovery Time	V <sub>R</sub> =50V , I <sub>F</sub> =5A , dl/dt=100A/us		40		nS
Q <sub>rr</sub>	Reverse Recovery Charge			43		nC

NOTES :

1. Repetitive rating : pulsed width limited by maximum junction temperature.

2.  $V_{\text{DD}}\text{=}25\text{V},$   $V_{\text{GS}}\text{=}10\text{V},$  L=0.1mH, I\_{\text{AS}}\text{=}8\text{A}.

3. The data tested by pulsed , pulse width  $\leq$  300us , duty cycle  $\leq$  2%.

4. The data is theoretically the same as ID and IDM , in real applications , should be limited by total power dissipation.



# Ph Rolls

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#### **Characteristics Curves**

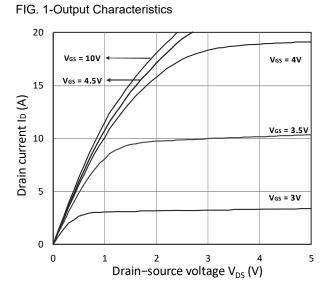
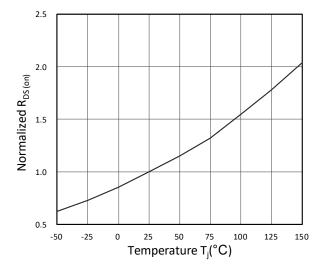
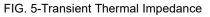
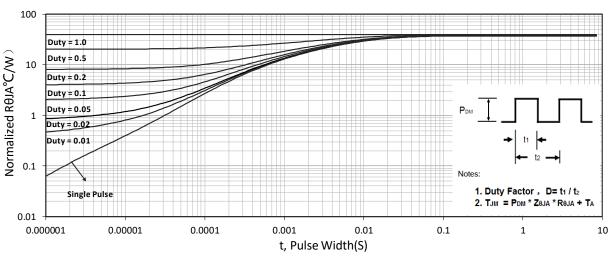


FIG. 3-Normalized  $R_{\text{DS(on)}}\,\text{vs.}~T_{\text{J}}$ 







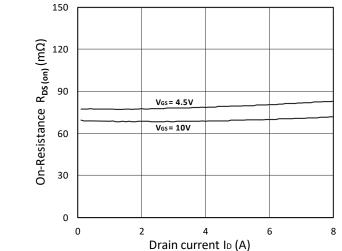
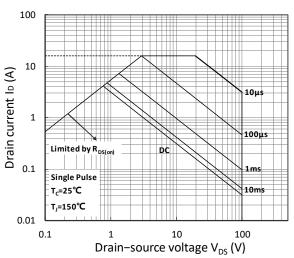


FIG. 4-Safe Operating Area

FIG. 2-R<sub>DS(ON)</sub> vs. I<sub>D</sub>

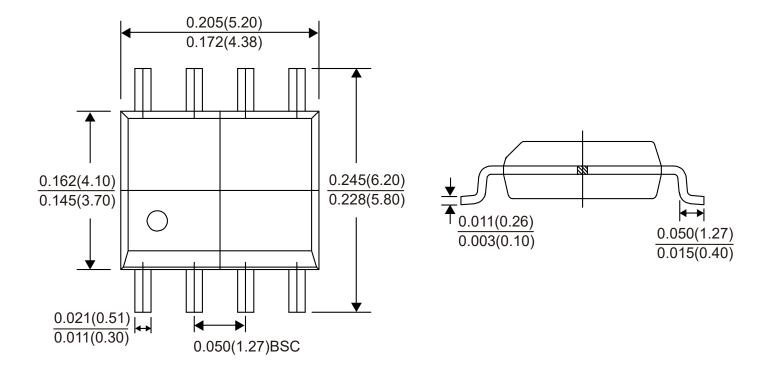


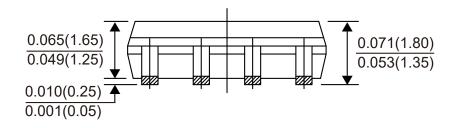


### Pb, RoHS

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#### Package Outline Dimensions





**SOP-8** Dimensions in inches and (millimeters)



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